	•	Se	ar	ch	No	ote	S	

Application/Control No.	Applicant(s)/Patent under Reexamination	7
10/792,231	LIN, YU-KAI	
Examiner	Art Unit	
Biju Chandran	2835	

SEARCHED				
Class	Subclass	Date	Examiner	
361	707	3/7/2006	BIC	

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	1				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
see search history				